



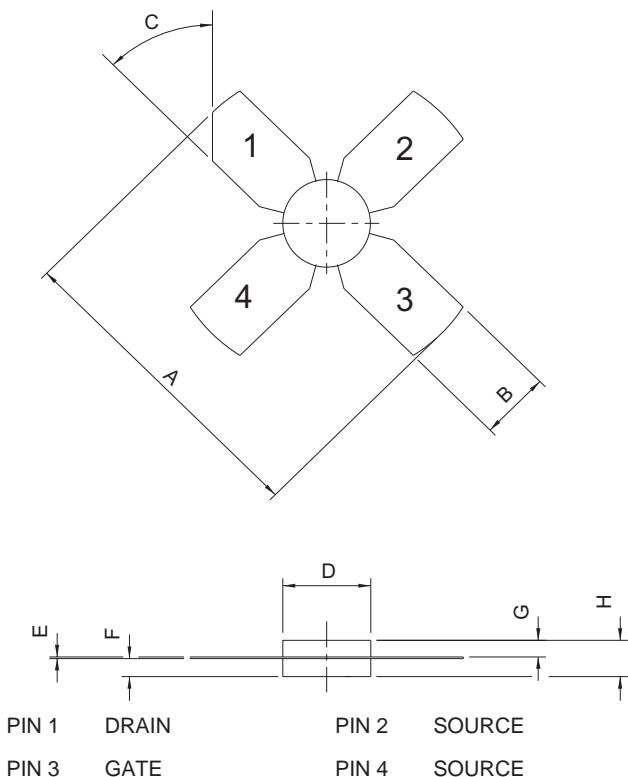
**SEME
LAB**

TetraFET

D1019UK

METAL GATE RF SILICON FET

MECHANICAL DATA



GOLD METALLISED MULTI-PURPOSE SILICON DMOS RF FET 20W – 28V – 175MHz SINGLE ENDED

FEATURES

- SIMPLIFIED AMPLIFIER DESIGN
- SUITABLE FOR BROAD BAND APPLICATIONS
- LOW C_{rss}
- SIMPLE BIAS CIRCUITS
- LOW NOISE
- HIGH GAIN – 16 dB MINIMUM

APPLICATIONS

- HF/VHF/UHF COMMUNICATIONS
from 1 MHz to 175 MHz

| DIM. | mm | Tol. | Inches | Tol. |
|------|-------|------|--------|-------|
| A | 26.16 | 0.13 | 1.030 | 0.015 |
| B | 5.72 | 0.13 | 0.225 | 0.005 |
| C | 45° | 5° | 45° | 5° |
| D | 7.11 | 0.13 | 0.280 | 0.005 |
| E | 0.13 | 0.02 | 0.005 | 0.001 |
| F | 1.52 | 0.13 | 0.055 | 0.005 |
| G | 0.43 | 0.20 | 0.060 | 0.008 |
| H | 7.67 | REF | 0.120 | REF |

ABSOLUTE MAXIMUM RATINGS ($T_{case} = 25^\circ\text{C}$ unless otherwise stated)

| | | |
|--------------|--|------------------|
| P_D | Power Dissipation | 50W |
| BV_{DSS} | Drain – Source Breakdown Voltage | 70V |
| BV_{GSS} | Gate – Source Breakdown Voltage | $\pm 20\text{V}$ |
| $I_{D(sat)}$ | Drain Current | 5A |
| T_{stg} | Storage Temperature | -65 to 150°C |
| T_j | Maximum Operating Junction Temperature | 200°C |



**SEME
LAB**

D1019UK

ELECTRICAL CHARACTERISTICS ($T_{case} = 25^\circ C$ unless otherwise stated)

| Parameter | Test Conditions | | Min. | Typ. | Max. | Unit |
|--------------|---------------------------------|----------------|-------------------|------|------|---------|
| BV_{DSS} | Drain–Source Breakdown Voltage | $V_{GS} = 0$ | $I_D = 100mA$ | 70 | | V |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = 28V$ | $V_{GS} = 0$ | | 1 | mA |
| I_{GSS} | Gate Leakage Current | $V_{GS} = 20V$ | $V_{DS} = 0$ | | 1 | μA |
| $V_{GS(th)}$ | Gate Threshold Voltage* | $I_D = 10mA$ | $V_{DS} = V_{GS}$ | 1 | 7 | V |
| g_{fs} | Forward Transconductance* | $V_{DS} = 10V$ | $I_D = 1A$ | 0.8 | | S |
| G_Ps | Common Source Power Gain | $P_O = 20W$ | | 16 | | dB |
| η | Drain Efficiency | $V_{DS} = 28V$ | $I_{DQ} = 0.1A$ | 50 | | % |
| VSWR | Load Mismatch Tolerance | $f = 175MHz$ | | 20:1 | | — |
| C_{iss} | Input Capacitance | $V_{DS} = 28V$ | $V_{GS} = -5V$ | | 60 | pF |
| C_{oss} | Output Capacitance | $V_{DS} = 28V$ | $V_{GS} = 0$ | | 30 | pF |
| C_{rss} | Reverse Transfer Capacitance | $V_{DS} = 28V$ | $V_{GS} = 0$ | | 2.5 | pF |

* Pulse Test: Pulse Duration = 300 μs , Duty Cycle $\leq 2\%$

HAZARDOUS MATERIAL WARNING

The ceramic portion of the device between leads and metal flange is beryllium oxide. Beryllium oxide dust is highly toxic and care must be taken during handling and mounting to avoid damage to this area.

THESE DEVICES MUST NEVER BE THROWN AWAY WITH GENERAL INDUSTRIAL OR DOMESTIC WASTE.

THERMAL DATA

| | | |
|----------------|------------------------------------|----------------|
| $R_{THj-case}$ | Thermal Resistance Junction – Case | Max. 3.5°C / W |
|----------------|------------------------------------|----------------|



**SEME
LAB**

D1019UK

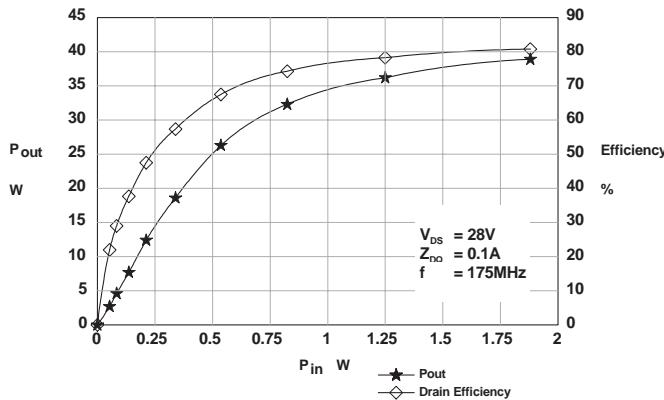


Figure 1 – Power Output and Efficiency vs. Power Input.

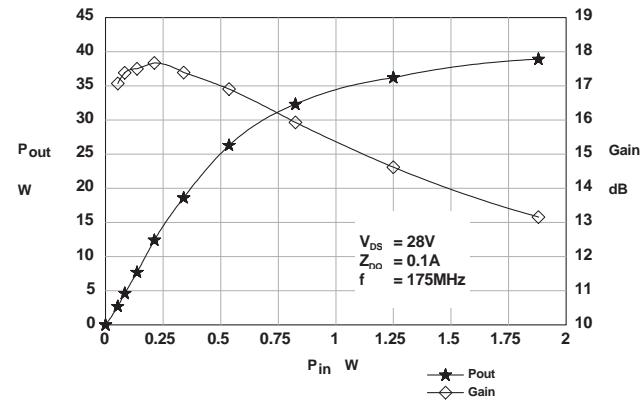


Figure 2 – Power Output & Gain vs. Power Input.

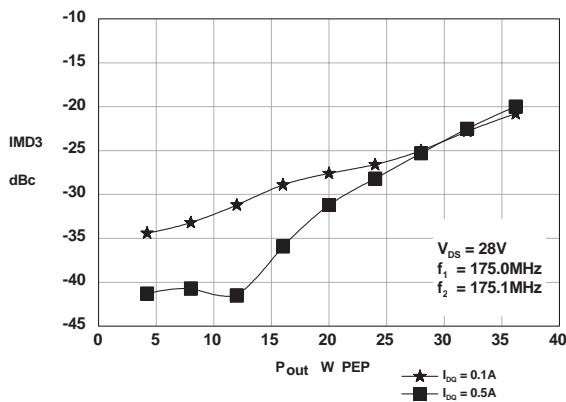


Figure 3 – IMD vs. Output Power.

D1019UK **OPTIMUM SOURCE AND LOAD IMPEDANCE**

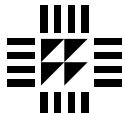
| Frequency MHz | Z_S Ω | Z_L Ω |
|------------------|-------------------|-------------------|
| 175MHz | $5 + j14$ | $12 - j14$ |

Typical S Parameters

! $V_{DS} = 28V$, $I_{DQ} = 0.1A$

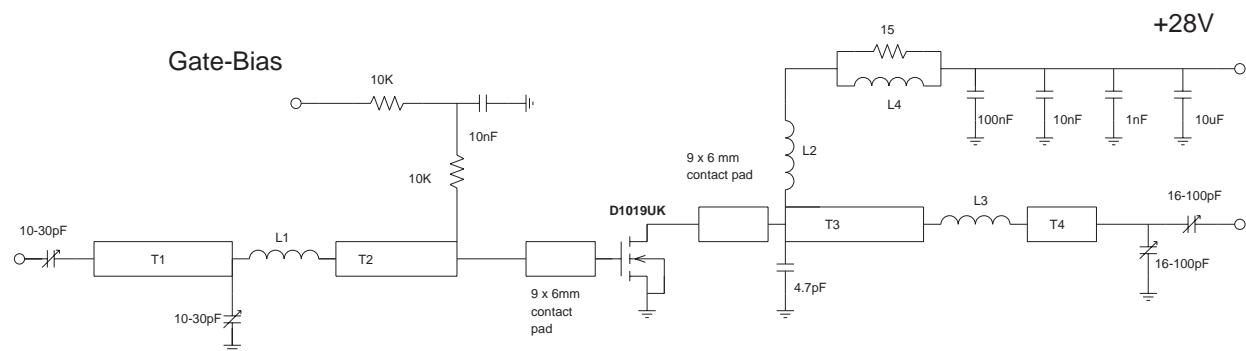
MHZ S MA R 50

| Freq MHz | S11 mag | S11 ang | S21 mag | S21 ang | S12 mag | S12 ang | S22 mag | S22 ang |
|-------------|------------|------------|------------|------------|------------|------------|------------|------------|
| 50 | 0.780 | -116 | 18 | 112 | 0.034 | 25 | 0.642 | -85 |
| 100 | 0.775 | -135 | 9.312 | 85 | 0.030 | 11 | 0.577 | -103 |
| 150 | 0.795 | -149 | 6.077 | 68 | 0.022 | 14 | 0.613 | -116 |
| 200 | 0.826 | -159 | 4.193 | 53 | 0.017 | 44 | 0.669 | -128 |
| 250 | 0.853 | -169 | 3.216 | 43 | 0.023 | 74 | 0.715 | -139 |
| 300 | 0.878 | -179 | 2.566 | 35 | 0.039 | 89 | 0.759 | -150 |
| 350 | 0.903 | 171 | 1.991 | 23 | 0.052 | 86 | 0.801 | -161 |
| 400 | 0.923 | 161 | 1.655 | 18 | 0.070 | 84 | 0.839 | -173 |
| 450 | 0.944 | 151 | 1.322 | 9 | 0.080 | 80 | 0.878 | 177 |
| 500 | 0.963 | 142 | 1.121 | 4 | 0.098 | 76 | 0.914 | 167 |
| 550 | 0.978 | 136 | 0.899 | -2 | 0.108 | 72 | 0.945 | 159 |
| 600 | 0.985 | 131 | 0.762 | -7 | 0.119 | 66 | 0.966 | 153 |



**SEME
LAB**

D1019UK



D1019UK 175MHz TEST FIXTURE

Substrate 1.6mm PTFE/glass, Er=2.5
All microstrip lines W=4.4mm

T1 10mm
T2 13mm
T3 12mm
T4 4mm

L1 1.5 turns 22swg enamelled copper wire, 6mm i.d.
L2 10 turns 19swg enamelled copper wire, 6mm i.d.
L3 1.5 turns 22swg enamelled copper wire, 6mm i.d.
L4 13.5 turns 19swg enamelled copper wire on
Siemens B64920A618X830 ferrite core